

**REVISIONS**

LTR	DESCRIPTION	DATE (YR-MO-DA)	APPROVED
A	Added subgroup 4 to Table IIA. Editorial changes throughout. – lgt	01-03-16	Raymond Monnin
B	Added subgroup 9 to Table IIA. Editorial changes throughout. – lgt	01-05-24	Raymond Monnin
C	Added outline I to 1.2.4. Updated figure 1 and 1.3. – gt	03-04-03	Raymond Monnin
D	Update drawing to current MIL-PRF-38535 requirements. -rrp	10-01-19	Charles F. Saffle
E	Update drawing to current MIL-PRF-38535 requirements. Removed class M references. -rrp	16-08-09	Charles F. Saffle



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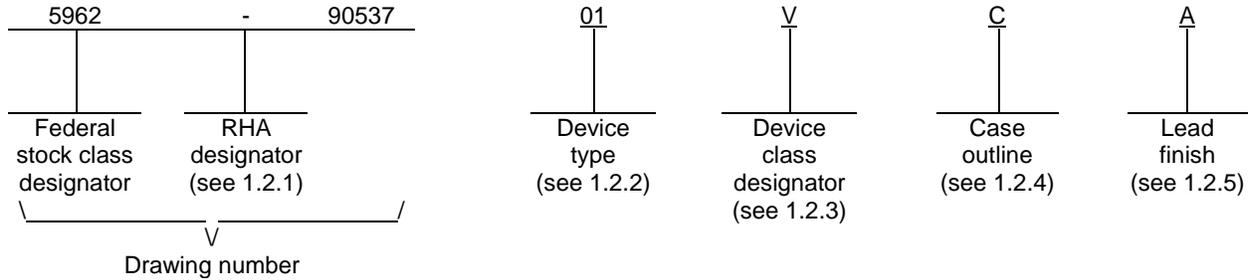
REV STATUS	REV	E	E	E	E	E	E	E	E	E	E								
OF SHEETS	SHEET	1	2	3	4	5	6	7	8	9									

PMIC N/A	PREPARED BY L.G. TRAYLOR	<p align="center"><b>DLA LAND AND MARITIME</b>  <b>COLUMBUS, OHIO 43218-3990</b>  <a href="http://www.landandmaritime.dla.mil">http://www.landandmaritime.dla.mil</a></p>																	
<p align="center"><b>STANDARD MICROCIRCUIT DRAWING</b></p> <p>THIS DRAWING IS AVAILABLE FOR USE BY ALL DEPARTMENTS AND AGENCIES OF THE DEPARTMENT OF DEFENSE</p> <p align="center">AMSC N/A</p>	CHECKED BY RAJ PITHADIA																		
	APPROVED BY RAYMOND MONNIN	<p align="center"><b>MICROCIRCUIT, LINEAR, INTERNALLY TRIMMED PRECISION IC MULTIPLIER, MONOLITHIC SILICON</b></p>																	
	DRAWING APPROVAL DATE 00-09-13																		
	REVISION LEVEL E		<table border="1"> <tr> <td>SIZE A</td> <td>CAGE CODE <b>67268</b></td> <td><b>5962-90537</b></td> </tr> </table>	SIZE A	CAGE CODE <b>67268</b>	<b>5962-90537</b>													
SIZE A	CAGE CODE <b>67268</b>	<b>5962-90537</b>																	
		SHEET	1 OF 9																

1. SCOPE

1.1 Scope. This drawing documents two product assurance class levels consisting of high reliability (device class Q) and space application (device class V). A choice of case outlines and lead finishes are available and are reflected in the Part or Identifying Number (PIN). When available, a choice of Radiation Hardness Assurance (RHA) levels is reflected in the PIN.

1.2 PIN. The PIN is as shown in the following example:



1.2.1 RHA designator. Device classes Q and V RHA marked devices meet the MIL-PRF-38535 specified RHA levels and are marked with the appropriate RHA designator. A dash (-) indicates a non-RHA device.

1.2.2 Device type(s). The device type(s) identify the circuit function as follows:

<u>Device type</u>	<u>Generic number</u>	<u>Circuit function</u>
01	AD534T	Internally trimmed precision IC multiplier

1.2.3 Device class designator. The device class designator is a single letter identifying the product assurance level as follows:

<u>Device class</u>	<u>Device requirements documentation</u>
Q or V	Certification and qualification to MIL-PRF-38535

1.2.4 Case outline(s). The case outline(s) are as designated in MIL-STD-1835 and as follows:

<u>Outline letter</u>	<u>Descriptive designator</u>	<u>Terminals</u>	<u>Package style</u>
C	CDIP2-T14	14	Dual-in-line
I	MACY1-X10	10	Can

1.2.5 Lead finish. The lead finish is as specified in MIL-PRF-38535 for device classes Q and V.

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1.3 Absolute maximum ratings. 1/

Supply Voltage.....	±22 V
Power Dissipation .....	500 mW
Output Short-Circuit to Ground .....	Indefinite
Input Voltage X1, X2, Y1, Y2, Z1, Z2.....	±Vs
Storage Temperature Range .....	-65°C to +150°C
Lead Temperature (Soldering, 60 sec.) .....	+300°C
Thermal resistance, junction-to-case ( $\theta_{Jc}$ ) .....	See MIL-STD-1835
Thermal resistance, junction-to-ambient ( $\theta_{JA}$ )	
Case C .....	95°C/W
Case I .....	142°C/W

1.4 Recommended operating conditions.

Supply Voltage.....	±15 V
Operating Temperature Range .....	-55°C to +125°C

2. APPLICABLE DOCUMENTS

2.1 Government specification, standards, and handbooks. The following specification, standards, and handbooks form a part of this drawing to the extent specified herein. Unless otherwise specified, the issues of these documents are those cited in the solicitation or contract.

DEPARTMENT OF DEFENSE SPECIFICATION

MIL-PRF-38535 - Integrated Circuits, Manufacturing, General Specification for.

DEPARTMENT OF DEFENSE STANDARDS

MIL-STD-883 - Test Method Standard Microcircuits.  
MIL-STD-1835 - Interface Standard Electronic Component Case Outlines.

DEPARTMENT OF DEFENSE HANDBOOKS

MIL-HDBK-103 - List of Standard Microcircuit Drawings.  
MIL-HDBK-780 - Standard Microcircuit Drawings.

(Copies of these documents are available online at <http://quicksearch.dla.mil> or from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

1/ Stresses above the absolute maximum rating may cause permanent damage to the device. Extended operation at the maximum levels may degrade performance and affect reliability.

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### 3. REQUIREMENTS

3.1 Item requirements. The individual item requirements for device classes Q and V shall be in accordance with MIL-PRF-38535 as specified herein, or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38535 and herein for device classes Q and V.

3.2.1 Case outlines. The case outlines shall be in accordance with 1.2.4 herein.

3.2.2 Terminal connections. The terminal connections shall be as specified on figure 1.

3.3 Electrical performance characteristics and postirradiation parameter limits. Unless otherwise specified herein, the electrical performance characteristics and postirradiation parameter limits are as specified in table I and shall apply over the full ambient operating temperature range.

3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table IIA. The electrical tests for each subgroup are defined in table I.

3.5 Marking. The part shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's PIN may also be marked. For packages where marking of the entire SMD PIN number is not feasible due to space limitations, the manufacturer has the option of not marking the "5962-" on the device. For RHA product using this option, the RHA designator shall still be marked. Marking for device classes Q and V shall be in accordance with MIL-PRF-38535.

3.5.1 Certification/compliance mark. The certification mark for device classes Q and V shall be a "QML" or "Q" as required in MIL-PRF-38535.

3.6 Certificate of compliance. For device classes Q and V, a certificate of compliance shall be required from a QML-38535 listed manufacturer in order to supply to the requirements of this drawing (see 6.6.1 herein). The certificate of compliance submitted to DLA Land and Maritime-VA prior to listing as an approved source of supply for this drawing shall affirm that the manufacturer's product meets, for device classes Q and V, the requirements of MIL-PRF-38535 and herein.

3.7 Certificate of conformance. A certificate of conformance as required for device classes Q and V in MIL-PRF-38535.

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TABLE I. Electrical performance characteristics.

Test	Symbol	Conditions -55°C ≤ T <sub>A</sub> ≤ +125°C <sup>1/</sup> unless otherwise specified	Group A subgroups	Device type	Limits		Unit
					Min	Max	
Relative accuracy <sup>2/</sup>	R <sub>A</sub>	V <sub>X</sub> = -10 V, -10 V, +10 V, +10 V V <sub>Y</sub> = -10 V, +10 V, -10 V, +10 V	4	ALL		±0.5	%FS
			1, 2, 3			±1	
Multiplier accuracy Drift	TC <sub>MA</sub>		2, 3	ALL		±0.01	%/°C
Nonlinearity, X Input	NL <sub>X</sub>	V <sub>X</sub> = 20 V pk-pk, V <sub>Y</sub> = +10 V	4	ALL		±0.3	%
Nonlinearity, Y Input	NL <sub>Y</sub>	V <sub>Y</sub> = 20 V pk-pk, V <sub>X</sub> = +10 V	4	ALL		±0.1	%
Output offset voltage	V <sub>OS</sub>	V <sub>X</sub> = V <sub>Y</sub> = V <sub>Z</sub> = 0 V	1	ALL		±30	mV
			2, 3			±45	
			4			±15	
Output offset voltage drift	ΔV <sub>OS</sub> /ΔT		2, 3	ALL		±300	μV/°C
Offset voltage (X)	V <sub>OSX</sub>	V <sub>X</sub> = V <sub>Z</sub> = 0 V, V <sub>Y</sub> = ±10 V	1	ALL		±20	mV
			4			±10	
Offset voltage (Y)	V <sub>OSY</sub>	V <sub>Y</sub> = V <sub>Z</sub> = 0 V, V <sub>X</sub> = ±10 V	1	ALL		±20	mV
			4			±10	
Input bias current (X, Y, or Z)	I <sub>IB</sub>	V <sub>X</sub> = V <sub>Y</sub> = V <sub>Z</sub> = 0 V	1	ALL		±2	μA
Input offset current	I <sub>OS</sub>	V <sub>X</sub> = V <sub>Y</sub> = V <sub>Z</sub> = 0 V	1	ALL		±2	μA
Positive supply current	I <sub>CC</sub>	R <sub>L</sub> = No Load	1	ALL		6.0	mA
Negative supply current	I <sub>EE</sub>	R <sub>L</sub> = No Load	1	ALL		6.0	mA
Common mode rejection ratio	CMR <sub>X</sub>	-10 V ≤ V <sub>X</sub> ≤ +10 V, V <sub>Y</sub> = +10 V	4	ALL	70		dB
	CMR <sub>Y</sub>	-10 V ≤ V <sub>Y</sub> ≤ +10 V, V <sub>X</sub> = +10 V	4		70		
Output voltage swing	V <sub>OP</sub>		1, 2, 3	ALL	±11		V
1% amplitude error	A <sub>E</sub>	V <sub>X</sub> = 2 V pk-pk, C <sub>L</sub> = 1000 pF, V <sub>Y</sub> = +10 V	9	ALL	50		kHz
Feedthrough, X input <sup>3/</sup>	F <sub>RR</sub>	Y Nulled, X = 20 V pk-pk at 50Hz	9	ALL		±0.30	%FS
Feedthrough, Y input <sup>3/</sup>	F <sub>RR</sub>	X Nulled, Y = 20 V pk-pk at 50Hz	9	ALL		±0.10	%FS

<sup>1/</sup> V<sub>S</sub> = ±15 V unless otherwise specified.

<sup>2/</sup> Figures given are % of Full Scale, ±10V (i. e., 0.01% = 1mV).

<sup>3/</sup> Irreducible component due to nonlinearity: excludes effects of offsets.

**STANDARD  
MICROCIRCUIT DRAWING**

DLA LAND AND MARITIME  
COLUMBUS, OHIO 43218-3990

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Device type	01	
Case outlines	C	I
Terminal Number	Terminal Symbol	
1	X1	X2
2	X2	SF
3	NC	Y1
4	SF	Y2
5	NC	-Vs
6	Y1	Z2
7	Y2	Z1
8	-Vs	OUT
9	NC	+Vs
10	Z2	X1
11	Z1	-----
12	OUT	-----
13	NC	-----
14	+Vs	-----

NC = No connect

FIGURE 1. Terminal connections.

<b>STANDARD MICROCIRCUIT DRAWING</b> DLA LAND AND MARITIME COLUMBUS, OHIO 43218-3990	SIZE <b>A</b>		<b>5962-90537</b>
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#### 4. VERIFICATION

4.1 Sampling and inspection. For device classes Q and V, sampling and inspection procedures shall be in accordance with MIL-PRF-38535 or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein.

4.2 Screening. For device classes Q and V, screening shall be in accordance with MIL-PRF-38535, and shall be conducted on all devices prior to qualification and technology conformance inspection.

##### 4.2.1 Additional criteria for device classes Q and V.

- a. The burn-in test duration, test condition and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The burn-in test circuit shall be maintained under document revision level control of the device manufacturer's Technology Review Board (TRB) in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1015 of MIL-STD-883.
- b. Interim and final electrical test parameters shall be as specified in table IIA herein.
- c. Additional screening for device class V beyond the requirements of device class Q shall be as specified in MIL-PRF-38535, appendix B.

4.3 Qualification inspection for device classes Q and V. Qualification inspection for device classes Q and V shall be in accordance with MIL-PRF-38535. Inspections to be performed shall be those specified in MIL-PRF-38535 and herein for groups A, B, C, D, and E inspections (see 4.4.1 through 4.4.4).

4.4 Conformance inspection. Technology conformance inspection for classes Q and V shall be in accordance with MIL-PRF-38535 including groups A, B, C, D, and E inspections, and as specified herein.

##### 4.4.1 Group A inspection.

- a. Tests shall be as specified in table IIA herein.
- b. Subgroups 5, 6, 7, 8, 10, and 11 in table I, method 5005 of MIL-STD-883 shall be omitted.

4.4.2 Group C inspection. The group C inspection end-point electrical parameters shall be as specified in table IIA herein.

4.4.2.1 Additional criteria for device classes Q and V. The steady-state life test duration, test condition and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The test circuit shall be maintained under document revision level control by the device manufacturer's TRB in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in method 1005 of MIL-STD-883.

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TABLE IIA. Electrical test requirements.

Test requirements	Subgroups (in accordance with MIL-PRF-38535, table III)	
	Device class Q	Device class V
Interim electrical parameters (see 4.2)	1, 4	1, 4
Final electrical parameters (see 4.2)	1, 2, 3, 4 <u>1/</u>	1, 2, 3, 4, 9 <u>1/ 2/</u>
Group A test requirements (see 4.4)	1, 2, 3, 4	1, 2, 3, 4, 9
Group C end-point electrical parameters (see 4.4)	1, 4	1, 4 <u>2/</u>
Group D end-point electrical parameters (see 4.4)	1, 4	1, 4
Group E end-point electrical parameters (see 4.4)	-----	1, 4

1/ PDA applies to subgroup 1. Delta's excluded from PDA.

2/ Delta limits as specified in table IIB shall be required where specified, and delta limits shall be computed with reference to the previous endpoint electrical parameters.

Table IIB. 240 hour burn-in and group C end-point electrical parameters.

Parameter	Device type	Limit	Delta
R <sub>A</sub>	01	±0.5% FS	±0.1% FS

4.4.3 Group D inspection. The group D inspection end-point electrical parameters shall be as specified in table IIA herein.

4.4.4 Group E inspection. Group E inspection is required only for parts intended to be marked as radiation hardness assured (see 3.5 herein).

- a. End-point electrical parameters shall be as specified in table IIA herein.
- b. For device classes Q and V, the devices or test vehicle shall be subjected to radiation hardness assured tests as specified in MIL-PRF-38535 for the RHA level being tested. All device classes must meet the postirradiation end-point electrical parameter limits as defined in table I at T<sub>A</sub> = +25°C ±5°C, after exposure, to the subgroups specified in table IIA herein.

## 5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-PRF-38535 for device classes Q and V.

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6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use for Government microcircuit applications (original equipment), design applications, and logistics purposes.

6.1.1 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor prepared specification or drawing.

6.2 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished using DD Form 1692, Engineering Change Proposal.

6.3 Record of users. Military and industrial users should inform DLA Land and Maritime when a system application requires configuration control and which SMD's are applicable to that system. DLA Land and Maritime will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronic devices (FSC 5962) should contact DLA Land and Maritime-VA, telephone (614) 692-8108.

6.4 Comments. Comments on this drawing should be directed to DLA Land and Maritime-VA, Columbus, Ohio 43218-3990, or telephone (614) 692-0540.

6.5 Abbreviations, symbols, and definitions. The abbreviations, symbols, and definitions used herein are defined in MIL-PRF-38535 and MIL-HDBK-1331.

6.6 Sources of supply.

6.6.1 Sources of supply for device classes Q and V. Sources of supply for device classes Q and V are listed in MIL-HDBK-103 and QML-38535. The vendors listed in QML-38535 have submitted a certificate of compliance (see 3.6 herein) to DLA Land and Maritime-VA and have agreed to this drawing.

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STANDARD MICROCIRCUIT DRAWING BULLETIN

DATE: 16-08-09

Approved sources of supply for SMD 5962-90537 are listed below for immediate acquisition information only and shall be added to MIL-HDBK-103 and QML-38535 during the next revision. MIL-HDBK-103 and QML-38535 will be revised to include the addition or deletion of sources. The vendors listed below have agreed to this drawing and a certificate of compliance has been submitted to and accepted by DLA Land and Maritime-VA. This information bulletin is superseded by the next dated revision of MIL-HDBK-103 and QML-38535. DLA Land and Maritime maintains an online database of all current sources of supply at <https://landandmaritimeapps.dla.mil/programs/smcr/>.

Standard microcircuit drawing PIN <u>1/</u>	Vendor CAGE number	Vendor similar PIN <u>2/</u>
5962-9053701VCA	24355	AD534TD/QMLV
5962-9053701VIA	24355	AD534TH/QMLV

- 1/ The lead finish shown for each PIN representing a hermetic package is the most readily available from the manufacturer listed for that part. If the desired lead finish is not listed contact the vendor to determine its availability.
- 2/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE number

24355

Vendor name and address

Analog Devices, Inc.  
 Rt. 1 Industrial Park  
 PO Box 9106  
 Norwood, MA 02062  
 Point of Contact:  
 7910 Triad Center Drive  
 Greensboro, NC 27409-9605

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